



Electronic
components
and materials

PHILIPS

2650 INPUT/OUTPUT STRUCTURES
AND INTERFACES MP54

AN APPLICATION MEMO

signetics

INTRODUCTION

Interfacing a microprocessor to peripheral devices is an important part of a total microcomputer system design. The characteristics of the interface depend to a large extent on total system requirements and other factors such as CPU loading and data speed. The use of interrupts and/or DMA structures also have an impact on the system input/output structure. The design of an I/O interface is not limited to hardware, and hardware/software trade-offs must be considered.

This applications memo examines the use of the 2650's versatile set of I/O instructions and the interface between the 2650 and I/O ports. Interrupt and DMA-controlled I/O are not discussed. A number of application examples for both serial and parallel I/O are given. Several types of input, output, and bidirectional interface devices are also examined.

Basic I/O Structure of the 2650

The 2650 is equipped with extensive and versatile input and output facilities. It can perform both single bit input/output and 8-bit parallel input/output.

The single bit input and output, called Sense (pin 1) and Flag (pin 40), are associated with the Program Status Word Upper (PSWU). The Flag output always reflects the value of bit 6 of the PSWU, while bit 7 of the PSWU always reflects the value of the Sense input signal. The Sense and Flag signals can be monitored and controlled with the PSW instructions.

Parallel I/O can be accomplished using the extended or non-extended read and write instructions. The extended and non-extended types are distinguished by the state of the E/ \bar{N} E output of the 2650.

The non-extended I/O instructions are single-byte instructions which accomplish a 1-byte data transfer into or out of the 2650. They also control the state of the D/ \bar{C} output, which can be used as a 1-bit device address in small systems.

The extended I/O instructions are 2-byte instructions. When executing extended I/O instructions, the second byte of the instruction is output on the lower 8 bits of the address bus (ADR0-ADR7). This information is normally used as an I/O device address to select 1 of up to 256 input or output devices, but may also be used to output control or status signals.

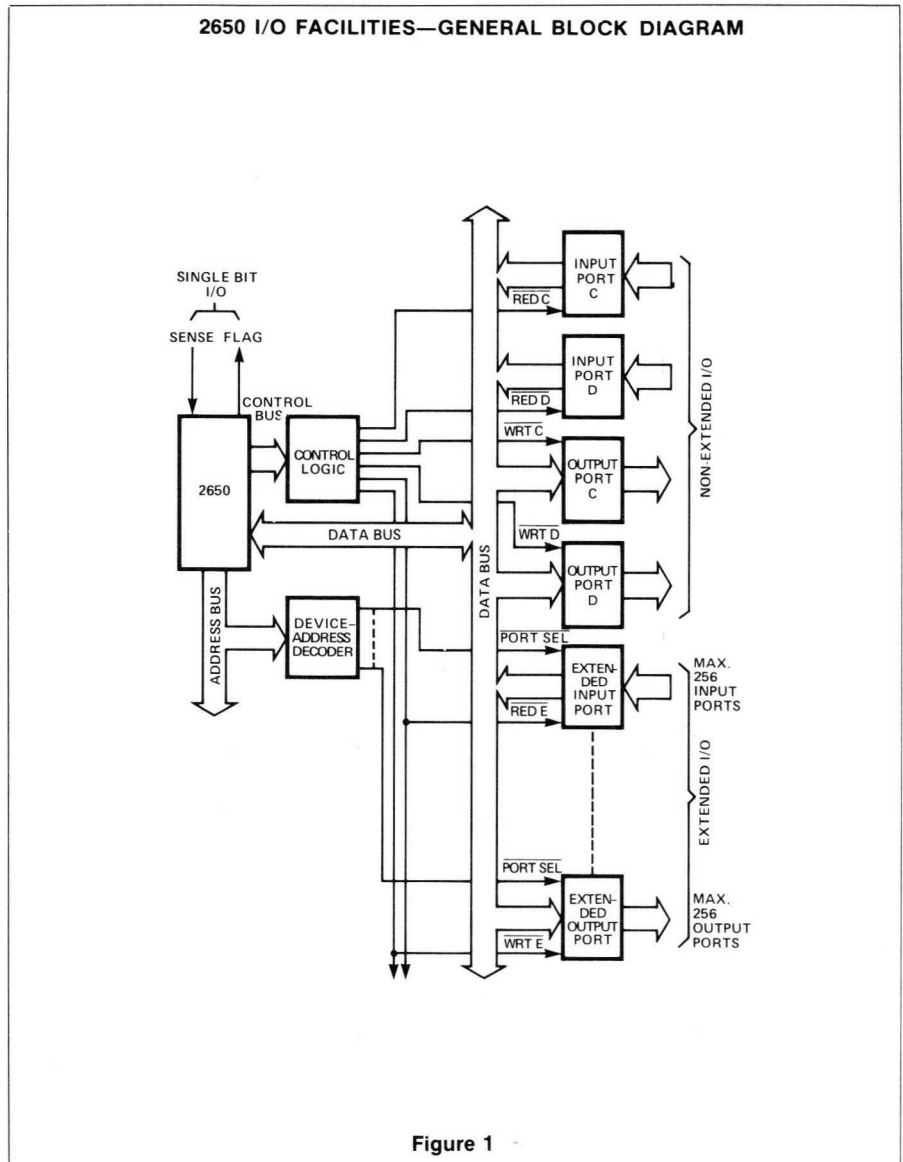


Figure 1

Parallel I/O operations may use any CPU register as the data source or destination. This offers significant flexibility in writing I/O software, because there is not a single accumulator register to create a "bottle-neck" in the data flow. The functional block diagram in Figure 1 illustrates the various I/O facilities.

I/O As Part of the Memory Address Space

The 2650 user may choose to transfer data into or out of the processor using the memory control signals. The advantage of this technique is that the data can be read or written by the program with memory load and store instructions, and data may be directly operated upon with logical and

arithmetic instructions. The memory referencing instructions can take advantage of the flexible addressing modes provided by the 2650, such as indexing and indirect addressing. A possible disadvantage of this method is that it may be necessary to decode more address lines to determine the device address than with the other I/O facilities.

To make use of this technique, the designer must assign memory addresses to I/O devices and design the device interfaces to respond to the same signals as memory.

I/O Interface Signals

Table I summarizes the state of the 2650 I/O interface signals for the various methods of I/O which are available.

SERIAL I/O USING THE SENSE INPUT AND FLAG OUTPUT

One of the I/O capabilities of the 2650 is provided by the sense input and flag output. The sense and flag pins may be used for single-bit input or output of status or control information. They can also be used to implement a serial data communications channel. Two examples of this application are given below.

Asynchronous Serial Communications Port

In applications where a serial type of terminal (like a teletypewriter) must be connected to the microcomputer system, the sense pin and flag pin can be used to interface with the terminal. The basic character format for asynchronous serial I/O is shown in Figure 2.

A number of parameters of this character format, and the transmission speed, are different for various types of terminals. The variable parameters are:

Baud rate (bits per second): 110, 150, 300, 600, 1200, 2400, 4800, and 9600 baud.

Number of bits per character: 5, 6, 7, or 8 bits.

Parity mode: even, odd, and no parity

Number of stop bits: 1 or 2

The control of the sense and flag pins for asynchronous serial I/O, with the appropriate parameters and baud rate, can be done completely with software. The hardware involved is limited to a simple line driver and receiver circuit which may be either an RS-232 interface or a 20mA current loop interface. The interface hardware is shown in Figure 3.

The software necessary to accomplish the serial I/O for a full-duplex line can be divided into 3 parts:

- The start bit detection and verification. After each start bit detection, the start-bit level is verified for a low level at time intervals of 1/6 of 1 bit time. This prevents false start-bit recognition caused by line noise.
- The sampling of the data bits at the mid-bit time, echoing the data bit to the flag output, and loading the data bit into a CPU register.
- The input, echo and check of parity bit and stop bits.

A timing diagram showing the start bit sampling and the bit echo appears in Figure 4.

TYPE OF I/O OPERATION	OPREQ	M/I \bar{O}	\bar{R}/W	ADRO-ADR7	ADR13 (E/ \bar{N} E)	ADR14 (D/ \bar{C})
Sense (Input)	X	X	X	X	X	X
Flag (Output)	X	X	X	X	X	X
Extended Read	H	L	L	Second Byte of Instruction	H	X
Extended Write	H	L	H	Second Byte of Instruction	H	X
Non-Extended Read C	H	L	L	X	L	L
Non-Extended Read D	H	L	L	X	L	H
Non-Extended Write C	H	L	H	X	L	L
Non-Extended Write D	H	L	H	X	L	H
Memory I/O Read	H	H	L	ADR0-ADR7	ADR13	ADR14
Memory I/O Write	H	H	H	ADR0-ADR7	ADR13	ADR14

X = Don't Care

Table 1 I/O INTERFACE SIGNAL STATE

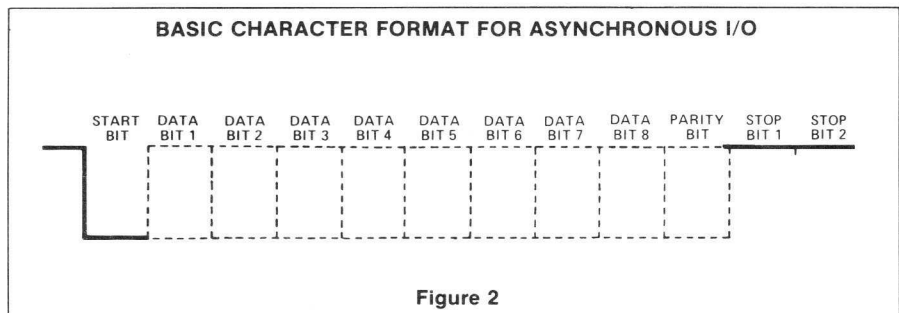


Figure 2

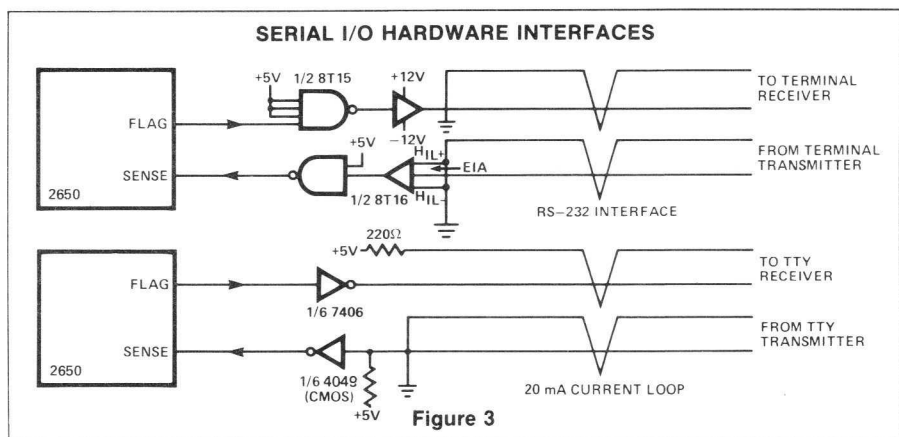


Figure 3

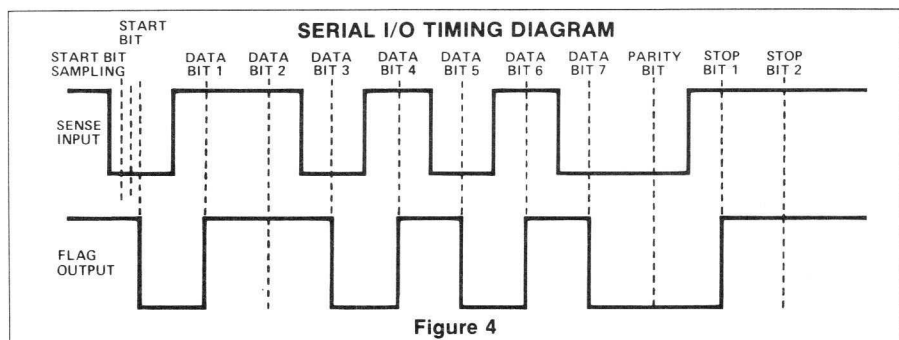


Figure 4

Three examples of the serial I/O routine with different speeds and parameters are presented in Figures 5 through 9. The bit and sample delay numbers (hexadecimal) in the definition listing (Figure 6) are for a CPU clock frequency of 1MHz. The hexadecimal delay numbers for a frequency of 1.25MHz are given in Table II. This table also lists the number of BDRR,R0 instructions that are necessary in the "bit delay and echo subroutine" to count cycles for the appropriate baud rate.

The examples of figures 7, 8, and 9 have the following parameters:

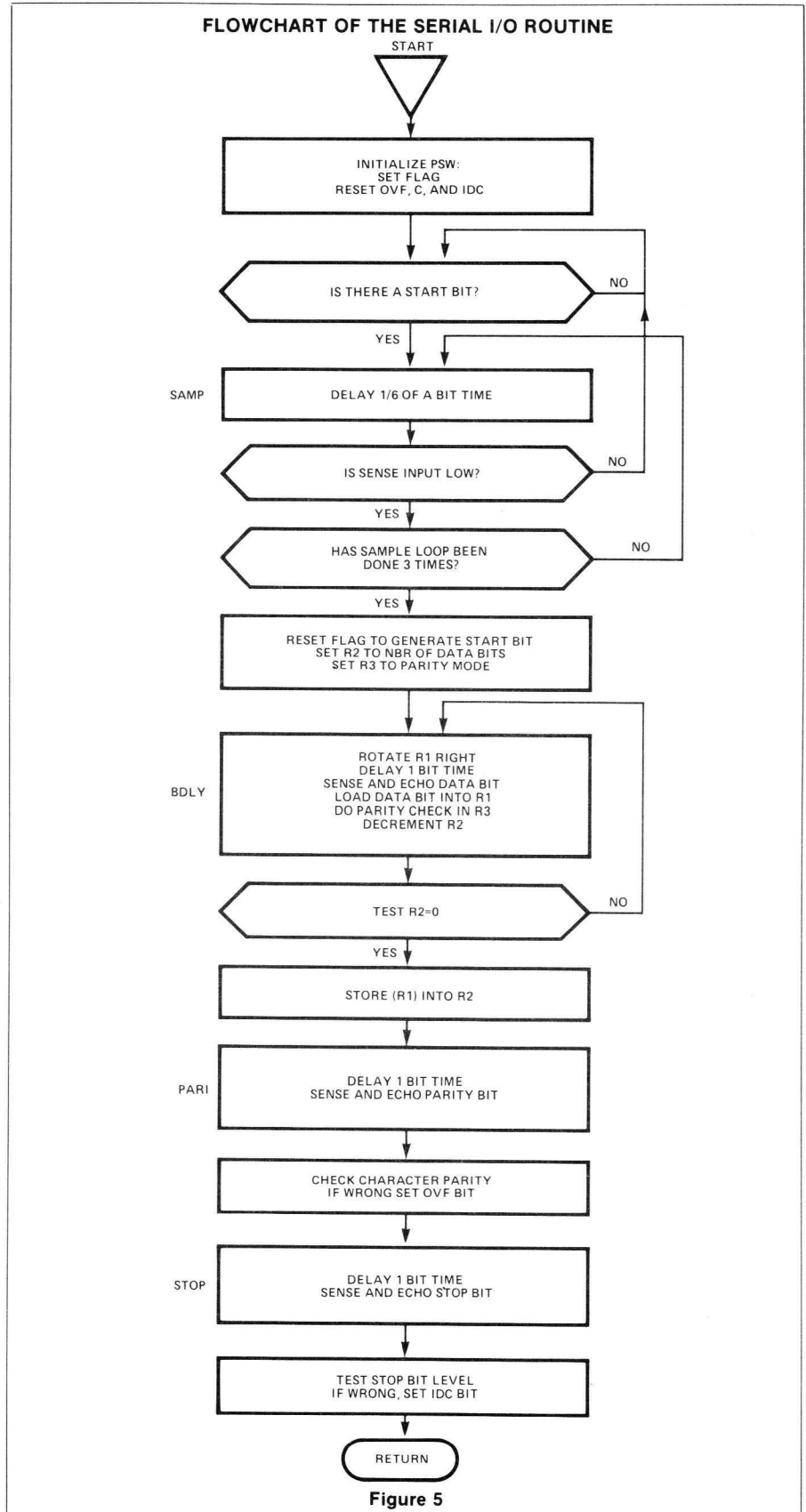
Figure 7: 110 baud, 7 data bits, even parity and 1 stop bit.

Figure 8: 600 baud, 7 data bits, odd parity and 2 stop bits.

Figure 9: 2400 baud, 8 data bits, no parity and 1 stop bit.

The serial I/O routine uses 4 CPU registers (1 bank and R0) and affects 7 of the Program Status Word bits; namely, Sense, Flag, Overflow, Carry, Interdigit Carry, and the 2 Condition Code bits. The program also uses 1 level of the return address stack.

A parity error will set the Overflow bit, and a framing error (wrong stop bit level) will set the Interdigit Carry bit. At the end of the routine, the input character is stored in register R2.



SERIAL I/O PARAMETER DEFINITIONS

```
TWIN ASSEMBLER VER 1.0 PAGE 0001
LINE ADDR OBJECT E SOURCE
0001 * P0760051
0002 *****
0003 *
0004 * **** PROGRAMMABLE SERIAL I/O ROUTINE ****
0005 *
0006 * WITH THIS PROGRAM THE SENSE AND FLAG INPUT/OUTPUT OF
0007 * THE 2650 ARE USED TO INTERFACE WITH TERMINALS
0008 * SUCH AS TTY, CRT TERMINALS, ETC. VIA THE BIT SERIAL
0009 * ASYNCHRONOUS LINE DISCIPLINE
0010 *
0011 * ALL CHARACTER AND LINE PARAMETERS CAN BE MODIFIED
0012 * SIMPLY IN THE SOFTWARE. THESE PARAMETERS ARE BAUD
0013 * RATE, NUMBER OF DATA BITS, PARITY MODE AND STOP BITS
0014 *
0015 * THE PROGRAM HAS BEEN SET UP FOR A FULL DUPLEX LINE
0016 * BUT CAN EASILY BE MODIFIED TO HALF DUPLEX MODE
0017 *
0018 *****
0019 * DEFINITIONS OF SYMBOLS
0020 *
0021 *
0022 0000 R0 EQU 0 PROCESSOR REGISTERS
0023 0001 R1 EQU 1
0024 0002 R2 EQU 2
0025 0003 R3 EQU 3
0026 0000 S EQU H'00' PSU: SENSE
0027 0040 F EQU H'40' FLAG
0028 0020 IDC EQU H'20' INTERDIGIT CARRY
0029 0004 OVF EQU H'04' OVERFLOW
0030 0001 C EQU H'01' CARRY/BORROW
0031 0002 N EQU 2 BRANCH CONDITION NEGATIVE
0032 0003 UN EQU 3 UNCONDITIONAL
0033 *
0034 *****
0035 *
0036 * SOFTWARE DEFINITIONS OF BAUD RATE, CHARACTER FORMAT, PARITY,
0037 * PARITY MODE, ETC
0038 *
0039 *
0040 * NUMBER OF DATA BITS
0041 *
0042 0000 DB8 EQU H'00' CHARACTER HAS 8 DATA BITS
0043 0000 BF8 EQU H'00'
0044 0007 DB7 EQU H'07' CHARACTER HAS 7 DATA BITS
0045 0040 BF7 EQU H'40'
0046 0006 DB6 EQU H'06' CHARACTER HAS 6 DATA BITS
0047 0020 BF6 EQU H'20'
0048 0005 DB5 EQU H'05' CHARACTER HAS 5 DATA BITS
0049 0010 BF5 EQU H'10'
0050 *
0051 * BIT DELAYS AT 1 MHZ CLOCK FREQUENCY
0052 *
0053 0000 BR01 EQU H'00' BIT DELAY AT 110 BAUD
0054 0000 BR03 EQU H'00' BIT DELAY AT 300 BAUD
0055 0000 BR06 EQU H'00' BIT DELAY AT 600 BAUD
0056 0053 BR12 EQU H'53' BIT DELAY AT 1200 BAUD
0057 0025 BR24 EQU H'25' BIT DELAY AT 2400 BAUD
0058 *
0059 * START BIT SAMPLE DELAYS AT 1 MHZ CLOCK FREQUENCY
0060 *
0061 0000 SD01 EQU H'00' SAMPLE DELAY AT 110 BAUD
0062 003A SD03 EQU H'3A' SAMPLE DELAY AT 300 BAUD
0063 0010 SD06 EQU H'10' SAMPLE DELAY AT 600 BAUD
0064 000C SD12 EQU H'0C' SAMPLE DELAY AT 1200 BAUD
0065 0005 SD24 EQU H'05' SAMPLE DELAY AT 2400 BAUD
0066 *
0067 * PARITY MODE
0068 *
0069 0000 EP EQU H'00' EVEN PARITY
0070 0000 OP EQU H'00' ODD PARITY
0071 *
```

Figure 6

SERIAL I/O ASSEMBLY LISTING—EXAMPLE 1

```
TWIN ASSEMBLER VER 1.0 PAGE 0003
LINE ADDR OBJECT E SOURCE
0073 *****
0074 * EXAMPLE 1. FULL DUPLEX (BIT BY BIT ECHO), 110 BAUD
0075 * 7 DATA BITS, EVEN PARITY AND 1 STOP BIT
0076 *
0077 0000 ORG H'0500'
0078 0500 7540 STRT PFSU F SET FLAG TO SWITCH OFF THE LINE
0079 0502 7525 CFSL OVF+C+IDC
0080 0504 12 TEST SPSU WAIT FOR START BIT
0081 0505 1A7D BCTR,N TEST
0082 0507 0602 LOO1,R2 H'03' SET R2 TO NUMBER OF SAMPLES
0083 0509 05A5 SAMP LOO1,R1 SOB1 SET R1 TO SAMPLE DELAY
0084 0508 F97E BARR,R1 #
0085 0500 12 SPSU TEST FOR START BIT VALIDITY
0086 0508 1A74 BCTR,N TEST IF NOT VALID, GO BACK TO TEST
0087 0510 FA77 BARR,R2 SAMP
0088 0512 0700 LOO1,R3 EP SET R3 TO EVEN PARITY MODE
0089 0514 0607 LOO1,R2 067 SET R2 TO NUMBER OF DATA BITS
0090 0516 7440 CFSU F GENERATE START BIT
0091 0518 51 BITS FRR,R1
0092 0519 3812 BSTR,UN B0LY GO TO DELAY AND ECHO ROUTINE
0093 051B FA78 BARR,R2 BITS TEST FOR NUMBER OF DATA BITS
0094 051D 01 LOO2 R1
0095 051E 02 STR2 R2 LOAD R2 WITH CHARACTER
0096 051F 3800 PARR BSTR,UN B0LY
0097 0521 9A02 BCFR,N STOP
0098 0523 7704 PPSL OVF IF WRONG PARITY, SET OVF
0099 0525 0700 STOP LOO1,R3 0 CLEAR R3
0100 0527 3804 BSTR,UN B0LY
0101 0529 16 EXIT1 RETC,N TEST STOP BIT LEVEL
0102 052B 7720 PPSL IDC IF WRONG, SET IDC BIT
0103 052C 17 EXIT2 RETC,UN
0104 *
0105 *****
0106 * BIT DELAY AND ECHO SUBROUTINE
0107 *
0108 0520 0A05 B0LY LOO1,R0 BR01 SET R0 TO BIT DELAY NUMBER
0109 052F F07E BARR,R0 #
0110 0531 F07E BARR,R0 #
0111 0533 F07E BARR,R0 #
0112 0535 F07E BARR,R0 #
0113 0537 12 SPSU TEST DATA BIT LEVEL
0114 0538 1A04 BCTR,N ONE
0115 053A 7440 CFSU F IF LOW, ECHO A ZERO
0116 053C 1004 BCTR,UN BIT1
0117 053E 7540 ONE PFSU F IF HIGH, ECHO A ONE
0118 0540 6540 IOB1,P1 0B7 INSERT DATA BIT INTO P1
0119 0542 25 BIT1 EOR2 R2
0120 0543 03 STP2 R2 GO PARITY CHECK
0121 0544 17 RETC,UN
0122 *
0123 0000 END 0
TOTAL ASSEMBLY ERRORS = 0000
```

Figure 7

SERIAL I/O ASSEMBLY LISTING

EXAMPLE 2

EXAMPLE 3

```
TWIN ASSEMBLER VER 1.0 PAGE 0003
LINE ADDR OBJECT E SOURCE
0073 * EXAMPLE 2: FULL DUPLEX (BIT BY BIT ECHO), 600 BAUD,
0074 * 7 DATA BITS, ODD PARITY AND 2 STOP BITS
0075 *
0076 *
0077 0000 ORG H'0500'
0078 0500 7640 STRT PPSU F SET FLAG TO SWITCH OFF THE LINE
0079 0502 7525 CP5L OVF+H+IDC
0080 0504 12 TEST SPSU WAIT FOR START BIT
0081 0505 1A7D BCTR,N TEST
0082 0507 0A03 L001,R2 H'03' SET R2 TO NUMBER OF SAMPLES
0083 0509 051C SAMP L001,R1 S0M6 SET R1 TO SAMPLE DELAY
0084 050B F97E BARR,R1 $
0085 050C 12 SPSU TEST FOR START BIT VALIDITY
0086 050E 1A74 BCTR,N TEST IF NOT VALID, GO BACK TO TEST
0087 0510 FA77 BARR,R2 SAMP
0088 0512 0780 L001,R3 0P SET R3 TO ODD PARITY MODE
0089 0514 0687 L001,R2 D07 SET R2 TO NUMBER OF DATA BITS
0090 0516 7440 CP5U F GENERATE START BIT
0091 0518 51 BITS RRR,R1
0092 0519 3B1A BSTR,UN B0LY GO TO DELAY AND ECHO ROUTINE
0093 051B FA7E BARR,R2 BITS TEST FOR NUMBER OF DATA BITS
0094 051D 01 L002 R1
0095 051E C2 STR2 R2 LOAD R2 WITH CHARACTER
0096 051F 3B14 PART BSTR,UN B0LY
0097 0521 9A02 BCFR,N ST01
0098 0523 7704 PPSL OVF IF WRONG PARITY, SET OVF
0099 0525 0700 ST01 L001,R3 0 CLEAR R3
0100 0527 3B0C BSTR,UN B0LY
0101 0529 1A02 BCTR,N ST02 TEST STOP BIT LEVEL
0102 052B 7720 PPSL IDC IF WRONG, SET IDC BIT
0103 052D 0700 ST02 L001,R3 0 CLEAR R3
0104 052F 3B04 BSTR,UN B0LY
0105 0531 16 EX11 RETC,N TEST STOP BIT 2 LEVEL
0106 0532 7720 PPSL IDC IF WRONG, SET IDC BIT
0107 0534 17 EX12 RETC,UN
0108 *
0109 *
0110 * BIT DELAY AND ECHO SUBROUTINE
0111 *
0112 0535 0400 B0LY L001,R0 B0M6 SET R0 TO BIT DELAY NUMBER
0113 0537 F87E BARR,R0 $
0114 0539 12 SPSU TEST DATA BIT LEVEL
0115 053B 1A04 BCTR,N ONE
0116 053D 7440 CP5U F IF LOW, ECHO A ZERO
0117 053E 1B04 BCTR,UN BIT1
0118 0540 7640 ONE PPSU F IF HIGH, ECHO A ONE
0119 0542 6540 IOR1,R1 B07 INSERT DATA BIT INTO R1
0120 0544 23 BIT1 EOR2 R3
0121 0545 C3 STR2 R3 DO PARITY CHECK
0122 0546 17 RETC,UN
0123 *
0124 0000 END 0
TOTAL ASSEMBLY ERRORS = 0000
```

Figure 8

```
TWIN ASSEMBLER VER 1.0 PAGE 0003
LINE ADDR OBJECT E SOURCE
0073 * EXAMPLE 3: FULL DUPLEX (BIT BY BIT ECHO), 2400 BAUD,
0074 * 8 DATA BITS, NO PARITY AND 1 STOP BIT
0075 *
0076 *
0077 0000 ORG H'0500'
0078 0500 7640 STRT PPSU F SET FLAG TO SWITCH OFF THE LINE
0079 0502 7525 CP5L OVF+H+IDC
0080 0504 12 TEST SPSU WAIT FOR START BIT
0081 0505 1A7D BCTR,N TEST
0082 0507 0A03 L001,R2 H'03' SET R2 TO NUMBER OF SAMPLES
0083 0509 0505 SAMP L001,R1 S024 SET R1 TO SAMPLE DELAY
0084 050B F97E BARR,R1 $
0085 050C 12 SPSU TEST FOR START BIT VALIDITY
0086 050E 1A74 BCTR,N TEST IF NOT VALID, GO BACK TO TEST
0087 0510 FA77 BARR,R2 SAMP
0088 0512 0600 L001,R2 D00 SET R2 TO NUMBER OF DATA BITS
0089 0514 7440 CP5U F GENERATE START BIT
0090 0516 51 BITS RRR,R1
0091 0517 3B0C BSTR,UN B0LY GO TO DELAY AND ECHO ROUTINE
0092 0519 FA7E BARR,R2 BITS TEST FOR NUMBER OF DATA BITS
0093 051B 01 L002 R1
0094 051C C2 STR2 R2 LOAD R2 WITH CHARACTER
0095 051D 0700 STOP L001,R3 0
0096 051F 3B04 BSTR,UN B0LY
0097 0521 16 EX11 RETC,N TEST STOP BIT LEVEL
0098 0522 7720 PPSL IDC IF WRONG, SET IDC BIT
0099 0524 17 EX12 RETC,UN
0100 *
0101 *
0102 * BIT DELAY AND ECHO SUBROUTINE
0103 *
0104 0525 0425 B0LY L001,R0 B024 SET R0 TO BIT DELAY NUMBER
0105 0527 F87E BARR,R0 $
0106 0529 12 SPSU TEST DATA BIT LEVEL
0107 052B 1A04 BCTR,N ONE
0108 052D 7440 CP5U F IF LOW, ECHO A ZERO
0109 052E 1B04 BCTR,UN BIT1
0110 0530 7640 ONE PPSU F IF HIGH, ECHO A ONE
0111 0532 6500 IOR1,R1 B08 INSERT DATA BIT INTO R1
0112 0534 C3 BIT1 STR2 R3
0113 0535 17 RETC,UN
0114 *
0115 0000 END 0
TOTAL ASSEMBLY ERRORS = 0000
```

Figure 9

BAUD RATE	SAMPLE DELAY NUMBER AT 1.25MHz	BIT DELAY NUMBER AT 1.25MHz	NUMBER OF BDRR,R0 INSTRUCTIONS AT 1.25MHz	NUMBER OF BDRR,R0 INSTRUCTIONS AT 1MHz
110	D0	E5	5	4
300	4A	C5	2	2
600	24	DE	1	1
1200	11	6A	1	1
2400	07	30	1	1

Table 2 BIT DELAY PROGRAM CONSTANTS AT A CLOCK FREQUENCY OF 1.25MHz (HEXADECIMAL)

Data String Output

A typical application for the flag output is a data string output. The advantage of this output method is that it can provide a large number of output bits with little address or control logic decoding. For example, this method can be used to output data for an array of numeric displays, single bit indicators, or column drivers of a parallel numeric printer. An example of the hardware required to implement this type of output channel is given in Figure 10.

Here, the Address 14 output is used as a data strobe signal. However, the data strobe signal could also be built up by decoding more address bits so that the system memory size would not be limited to 16K bytes as in this example.

A listing of the program required is given in Figure 14. The data is assumed to be located in the system's RAM as illustrated in Figure 11.

The least-significant bit of the least-significant byte will be output first. The table length (TLEN) and the number of bits per byte (BPW) can be adapted as necessary by software modifications. The data strobe pulse on output ADR14 is generated by doing the dummy instruction STRA,R0 to address H'4000'.

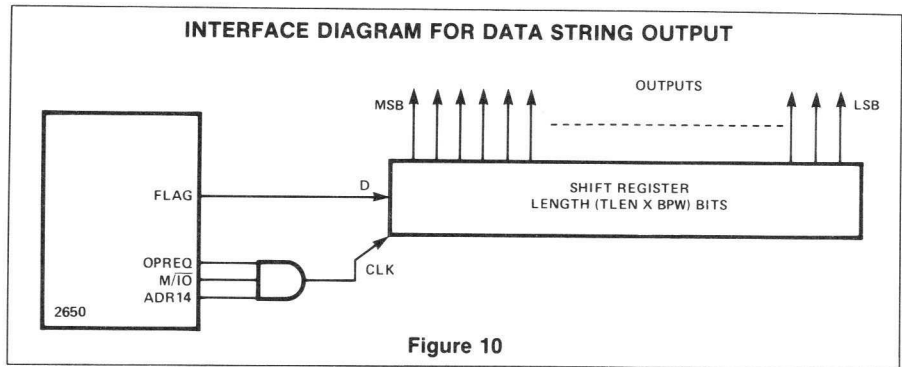


Figure 10

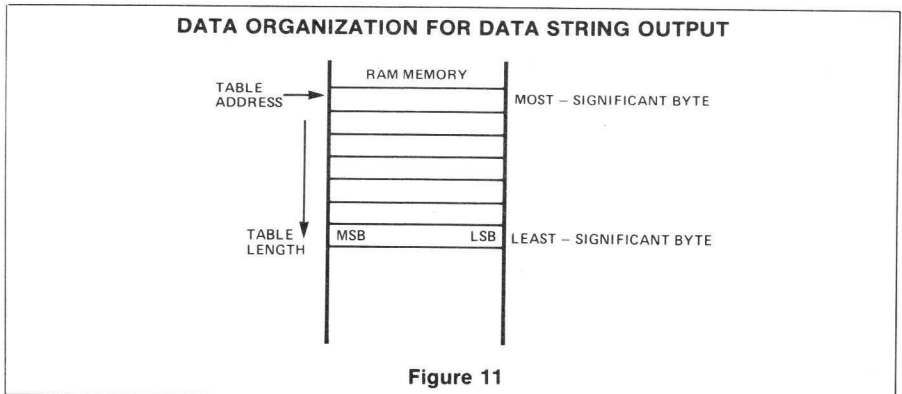


Figure 11

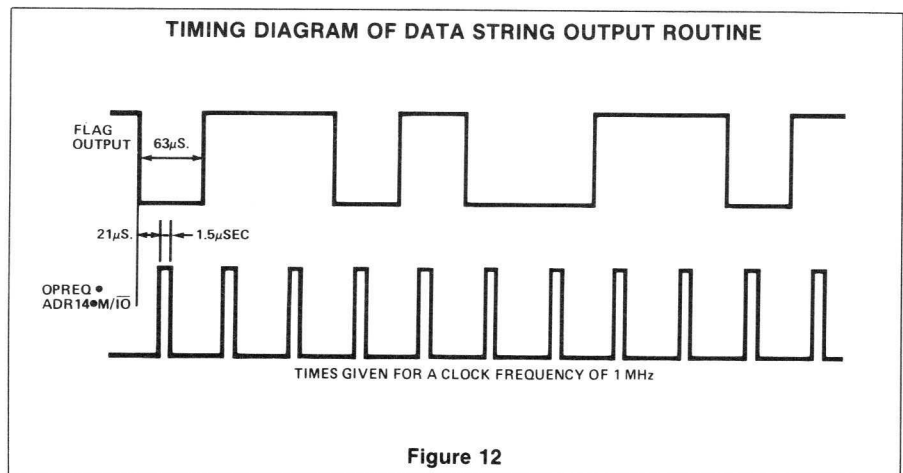


Figure 12

FLOWCHART OF DATA STRING OUTPUT ROUTINE

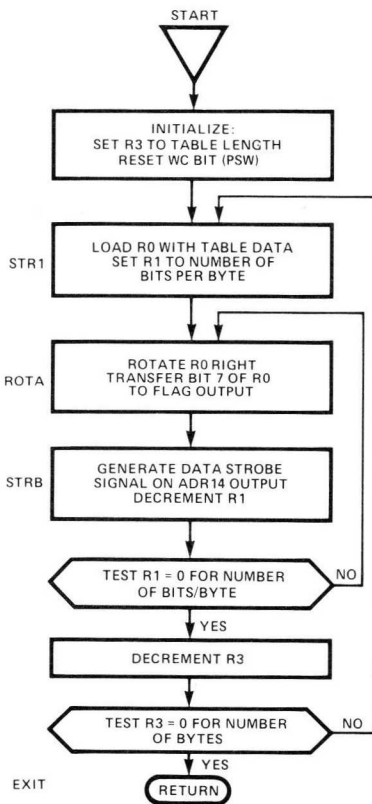


Figure 13

ASSEMBLY LISTING OF DATA STRING OUTPUT ROUTINE

```

MWIN ASSEMBLER VER 1.0 PAGE 0001
LINE ADDR OBJECT E SOURCE
0001 * P0720004
0002 * .....
0003 * **** DATA STRING OUTPUT ROUTINE ****
0004 * .....
0005 * THIS PROGRAM TRANSFERS THE CONTENTS OF A MEMORY TABLE IN BIT BY
0006 * BIT SERIAL FORM TO THE FLAG OUTPUT OF THE 2650
0007 * .....
0008 * THE TABLE LENGTH AND THE NUMBER OF BITS ARE SOFTWARE PROGRAMMED
0009 * .....
0010 * A DATA STROBE OUTPUT IS GENERATED ON THE ADDRESS 14 OUTPUT
0011 * .....
0012 * .....
0013 * .....
0014 * .....
0015 * DEFINITIONS OF SYMBOLS
0016 * .....
0017 0000 R0 EQU 0 PROCESSOR REGISTERS
0018 0001 R1 EQU 1
0019 0002 R2 EQU 2
0020 0003 R3 EQU 3
0021 0000 S EQU H'00' PSU SENSE
0022 0000 F EQU H'40' FLAG
0023 0000 MC EQU H'08' PSL 1=WITH 0=WITHOUT CARRY
0024 0002 N EQU 2 BRANCH COND NEGATIVE
0025 0003 UN EQU 3 UNCONDITIONAL
0026 * .....
0027 0007 TLEN EQU H'07' TABLE LENGTH
0028 0008 BFN EQU H'06' NUMBER OF BITS PER BYTE
0029 * .....
0030 0000 ORG H'0600'
0031 0600 TABEL RES TLEN LOCATION OF TABLE
0032 * .....
0033 * .....
0034 * .....
0035 0607 ORG H'0500'
0036 0500 0707 STR1 LODI R3 TLEN
0037 0502 7506 CPSL MC
0038 0504 0F5600 STR1 LODI R0 TABEL R3 LOAD R0 WITH TABLE DATA
0039 0507 0506 LODI R1 BFN SET R1 TO NUMBER OF BITS PER BYTE
0040 0509 50 ROTA RRR R0
0041 050A 1A06 BTR N ONE TEST BIT
0042 050C 7440 ZERO CPSU F IF ZERO, RESET FLAG
0043 050E 1B04 BTR UN STRB
0044 * .....
0045 0510 4000 HDR DATA H'40'00'
0046 * .....
0047 0512 7640 ONE PPSU F IF ONE, SET FLAG
0048 0514 0C0510 STRB STRA R0 HDR GENERATE STROBE SIGNAL ON R14
0049 0517 F970 BARR R1 ROTA TEST FOR NUMBER OF BITS
0050 0519 FB69 BARR R3 STR1 TEST FOR NUMBER OF BYTES
0051 051B 17 EXIT RETC UN
0052 0000 END 0
TOTAL ASSEMBLY ERRORS = 0000
    
```

Figure 14

PARALLEL INPUT/OUTPUT

The 2650 instruction set contains the following six input/output instructions:

		NO. BYTES
WRTC, RX	Write Control	1
REDC, RX	Read Control	1
WRTD, RX	Write Data	1
REDD, RX	Read Data	1
WRTE, RX DEVA	Write Extended	2
REDE, RX DEVA	Read Extended	2

The control signals generated by each I/O instruction simplify the interface circuitry required to generate I/O selection and timing signals. A low-cost control signal interface with related timing is shown in Figures 15 and 16.

When using standard TTL and 8T series I/O ports, the I/O operations can be done without slowing down the system. In this case the OPACK input could be controlled directly for all I/O operations.

Non-Extended I/O

The single-byte I/O instructions of the 2650 are referred to as non-extended I/O. In small systems with only two 8-bit input ports and two 8-bit output ports, this I/O facility requires a minimum of hardware interfacing between the CPU and I/O ports. The signals WRTC, WRTD, REDC, and REDD generated by the control logic decoder in Figure 15 can be used directly as output port clock pulses and input port enable signals, respectively.

Sequential I/O With Non-Extended I/O Instructions

In systems where a larger number of devices must be serviced in sequence, the use of a simple 8-bit output port can offer considerable savings in software. Normally the devices could be serviced with extended I/O instructions. However, since the device address is the second byte in this type of instruction, a series of data fetch and I/O instructions would be required to service the devices in sequence.

With an 8-bit output port functioning as a device address register, the device address can be modified under software control. In this way, a simple program loop can serve up to 8 I/O ports by rotating a single '1' through a CPU register that is output as a device address. This I/O addressing technique may also be used advantageously in systems where I/O operation requests are detected by software polling. A functional block diagram of this technique is shown in Figure 17.

Extended I/O

There are 2 extended I/O instructions in the 2650 instruction set. In these 2-byte instructions, the first byte specifies the operation code and the data source or destination register in the CPU. The second byte provides an 8-bit device address code that is output on the 8 least-significant bits of the address bus, ADR0 through ADR7.

The control signal decoding diagram (Figure 15) can be simplified for systems using only extended I/O, as shown in Figure 18. The timing diagram of Figure 16 also applies to this decoding technique.

Device Address Decoding Schemes

For extended I/O it is necessary to decode the address lines ADR0 through ADR7 in order to generate appropriate port selection signals. The choice of an address decoding scheme depends on factors such as total

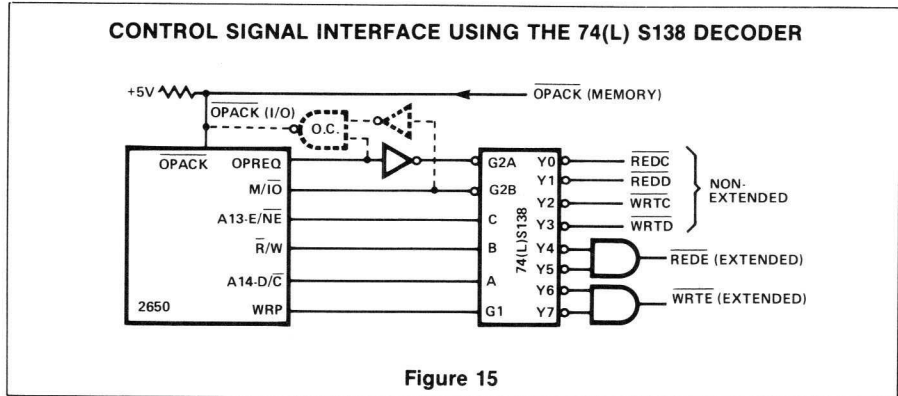


Figure 15

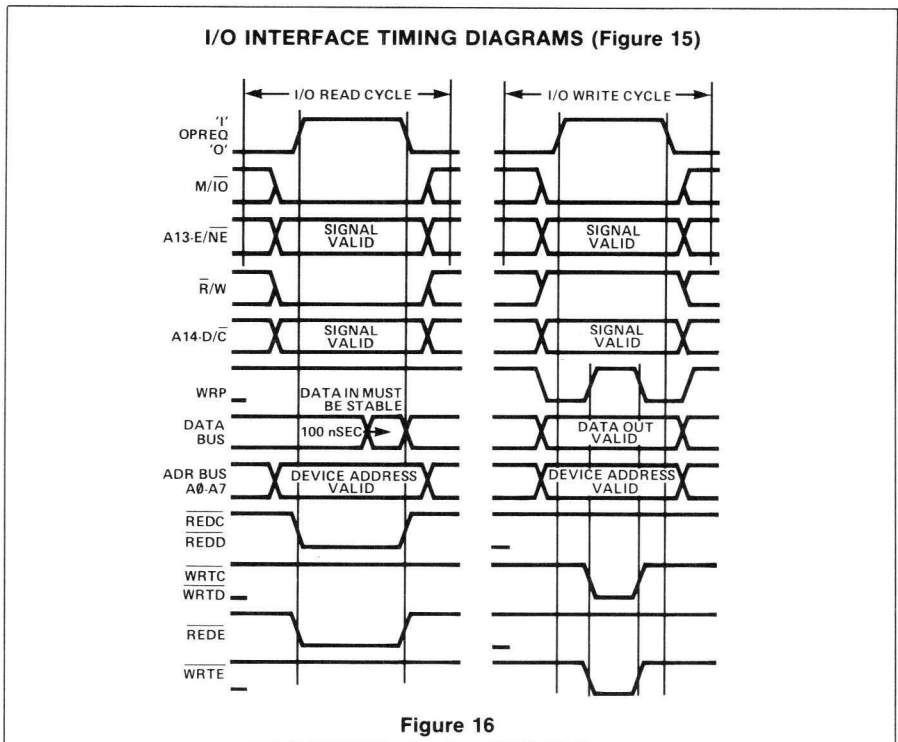


Figure 16

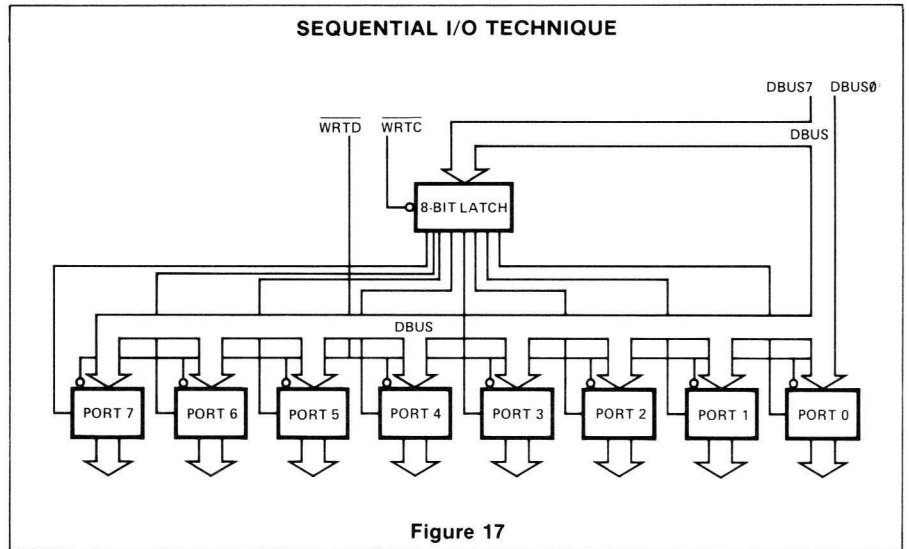
I/O requirements, the type of I/O ports used, and the total system configuration.

In principle, there are 2 basic methods of device address decoding. One method is the use of hardwired logic in which the device address is fixed; the other is a hardware programmable method in which the device addresses are individually set with jumpers or switches. Some examples of these methods are given in Figures 19 and 20.

In many applications a combination of these 2 methods is used. In addition, the control logic can be implemented as an integral part of the device address decoding. An example is shown in Figure 21.

Memory Mapped I/O

In memory mapped I/O, the I/O devices are treated as memory locations. An advantage of this technique is that all memory referencing instruction types (store, load, arithmetic, logical, etc.) can be used directly for I/O data. Device address decoding is not necessarily more complex than for normal extended I/O, since all I/O addresses could be located in a specific address block. Of course, this technique can only be used in systems which do not use the full memory address space for programs. A diagram of the I/O control logic, using the ADR14 output to discriminate between memory and I/O operations, is given in Figure 22. The device address decoding methods described earlier can also be applied to memory mapped I/O.



SIMPLIFIED CONTROL LOGIC WHEN USING EXTENDED I/O ONLY

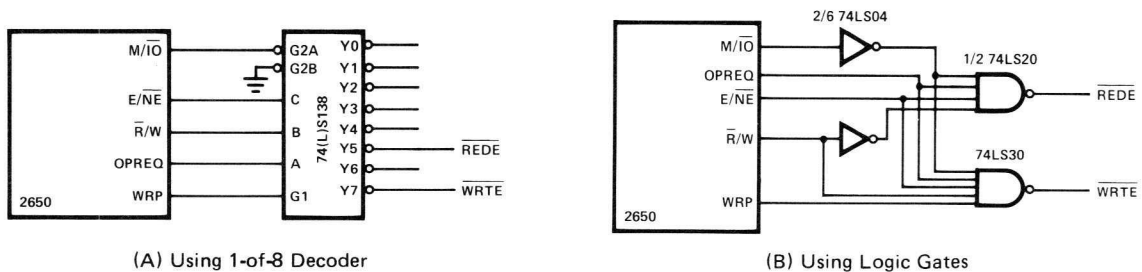


Figure 18

SOME POSSIBLE TECHNIQUES FOR DEVICE ADDRESS DECODING

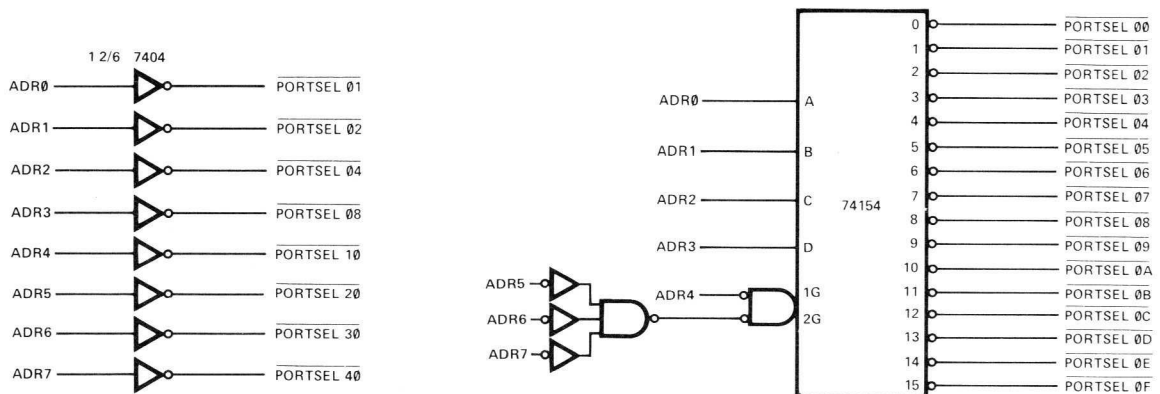
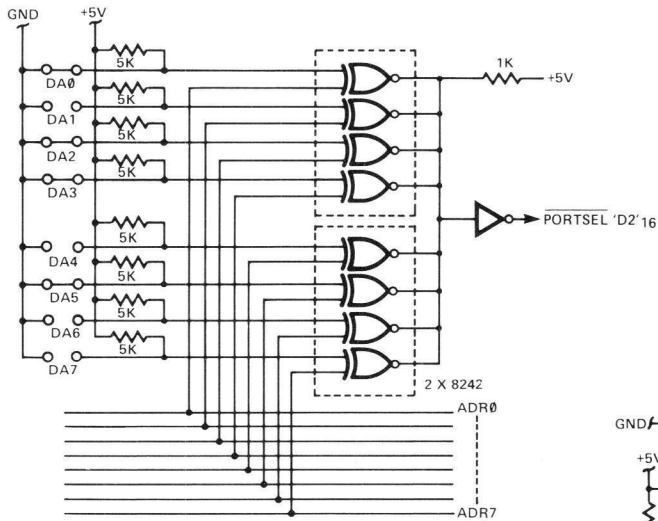
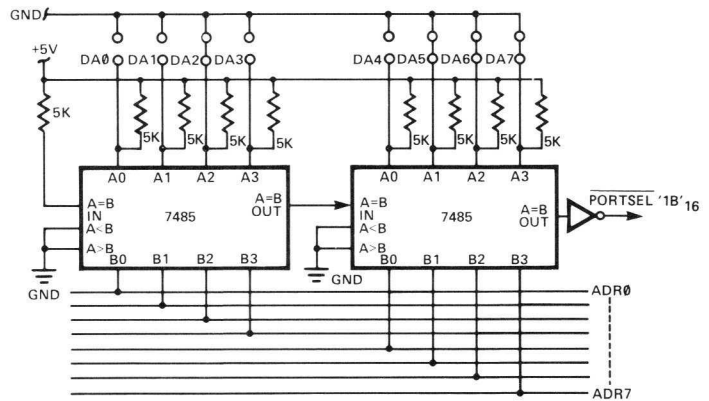


Figure 19

HARDWARE PROGRAMMABLE DEVICE ADDRESS DECODERS



(A) Using Exclusive-OR Gates



(B) Using Comparators

Figure 20

COMBINED CONTROL LOGIC AND ADDRESS DECODING

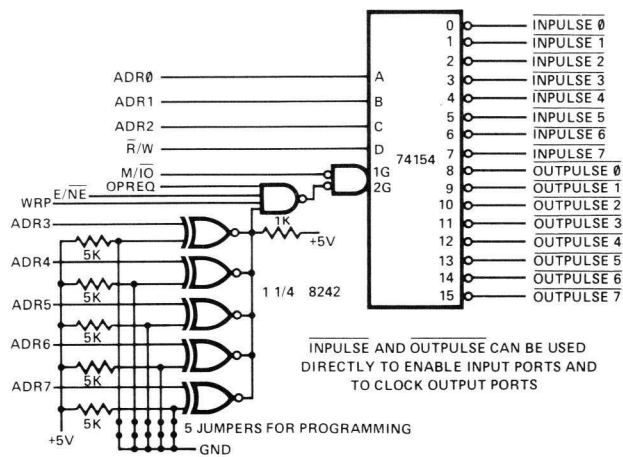


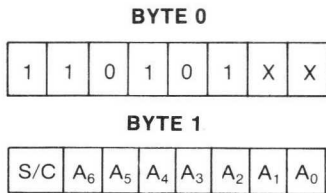
Figure 21

SINGLE POINT CONTROL

In many applications, the capability to set, clear, or test a single output point selected from a large number of output points is required. Designs of this type can be implemented using the 2650 I/O instructions. When used as described below, the WRTE, WRTC, and WRTD instructions become "set/clear single-bit" instructions, while the REDE instruction becomes a "test single-bit" instruction.

Single Bit Output—Direct Address

The write extended instruction can be used to select and set or clear a single output bit. The 2 bytes of the instruction can be interpreted as follows:



A₀ through A₆ of the second byte specify the output selected. The S/C bit specifies whether the bit is set or cleared. A typical hardware configuration controlling 64 points is shown in Figure 23. Here, the control line decoding and partial address decoding is done by the 74LS138, which selects one of the eight 9334s. One of the 8 latches in the selected 9334 is enabled by ADR₀, ADR₁, and ADR₂ and is either cleared or set, as determined by the value of ADR₇.

The XX field in the first byte selects 1 of the 4 available registers and outputs its contents on the data bus. Since this information is not used in this application, the value of XX is not important. However, it could be used to output an 8-bit control or status word in conjunction with the set/clear operation.

Single Bit Output—Indirect Address

If the address of the output to be set or cleared must be determined at program run time, the WRTD and WRTC instructions can be used. The address of the output bit is first loaded into one of the 2650 registers. A WRTD, Rx instruction is then issued if the bit is to be set, and a WRTC, Rx instruction is issued if the bit is to be cleared. The bit select is output on the data bus, and the D/ \bar{C} output carries the set/clear information. The hardware implementation can be the same as shown in Figure 23, except that ADR₀-ADR₅ are replaced by DBUS₀-DBUS₅, and ADR₇ is replaced by D/ \bar{C} .

I/O CONTROL SIGNAL GENERATION FOR MEMORY MAPPED I/O

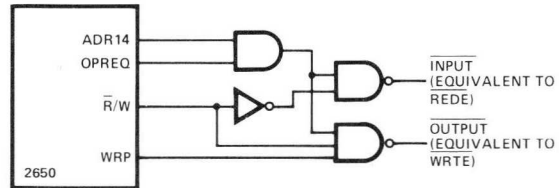


Figure 22

SIXTY-FOUR SINGLE BIT OUTPUTS USING THE 9334

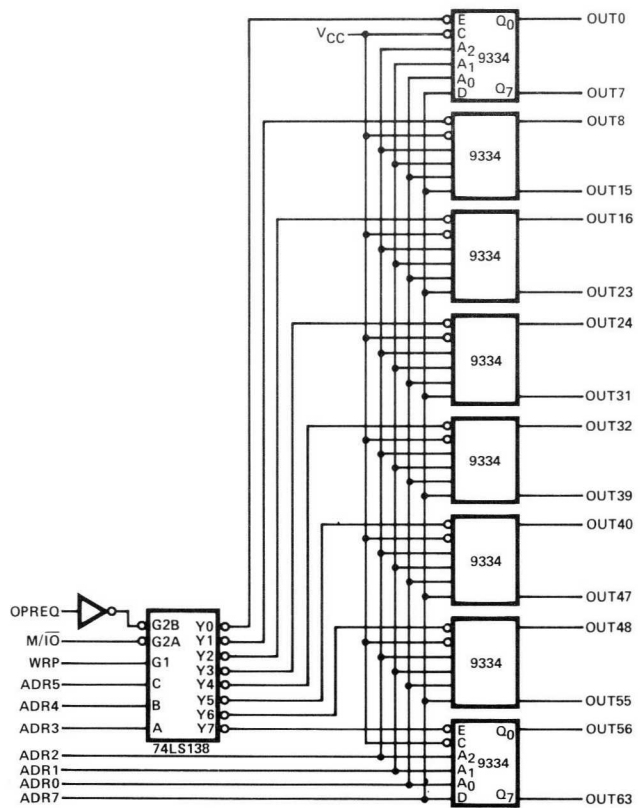


Figure 23

Single Bit Input

One way of doing single bit input uses the techniques described earlier. The address of the bit that is to be tested is loaded into one of the 2650 registers and output to an 8-bit latch using an extended or non-extended write instruction. The latch output is decoded to select the desired bit, which is then applied to the Sense input pin. The 2650 Program Status Word instructions can then be used to test the state of the Sense input and to take appropriate program action.

The technique described above must be used if "indirect" bit addressing is required. If this is not a requirement, a more efficient implementation can be accomplished using the extended read instruction. This technique makes use of the fact that the 2650 automatically tests the contents of a register every time it is used as the destination of an operation. Thus, when the read extended operation reads data from an input port, the condition code bits in the program status word are set to reflect whether the new

register contents is positive, negative, or zero.

For the single bit input application, the second byte of the RETE, Rx instruction contains the address of the input bit to be tested. This data is applied to a bank of data selectors to select the addressed bit, which is then applied to the most-significant bit of the data bus, DBUS7. Since this is interpreted as the sign bit, the condition code bits in PSL will be set to reflect whether the bit being tested is a one or a zero. A conditional branch instruction can then be used to affect the desired program action. A hardware implementation for 64 inputs is shown in Figure 24. Note that an address latch is not required for this method.

INPUT PORT DEVICES

Gated Input Ports

The simplest form of an input port is the tri-state gate. Figure 25 illustrates the use of the 8T97 high-speed hex tri-state buffer for gated input ports. The 8T97 is non-inverting, and the tri-state control signals enable the buffers in groups of 4 and groups of 2, so that 8-bit ports can be implemented efficiently.

An effective circuit for systems using 8-gated input ports is the 74251 8-to-1 multiplexer, which has tri-state outputs that can interface directly with the data bus. The advantage of this circuit is that no external address decoding logic is needed. A configuration using gated input ports with the 74251 multiplexer is illustrated in Figure 26.

In addition to these 2 configurations, many other input port configurations are possible using standard TTL or Signetics 8T series logic circuits.

Latching Input Ports

Latching input ports may be required to store data from an external device, which is available only momentarily, before the actual input operation to the microprocessor takes place. This type of input port can be realized by connecting TTL-latch or D-type flip-flop circuits, such as the 7475, 74100, or 74175, to the inputs of a gated input port. As illustrated in Figure 27, by using the Signetics 8T10 Quad D-type flip-flop with tri-state outputs, an 8-bit latching input port can be implemented with only 2 packages. The 8T10 is functionally identical to the 74173.

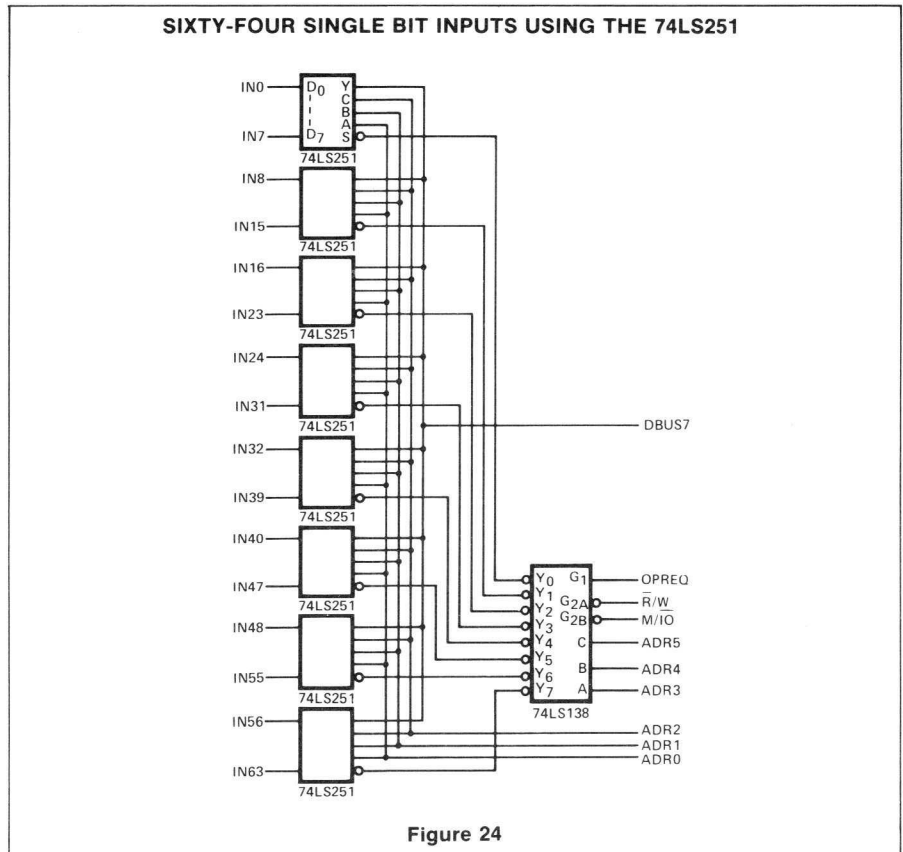


Figure 24

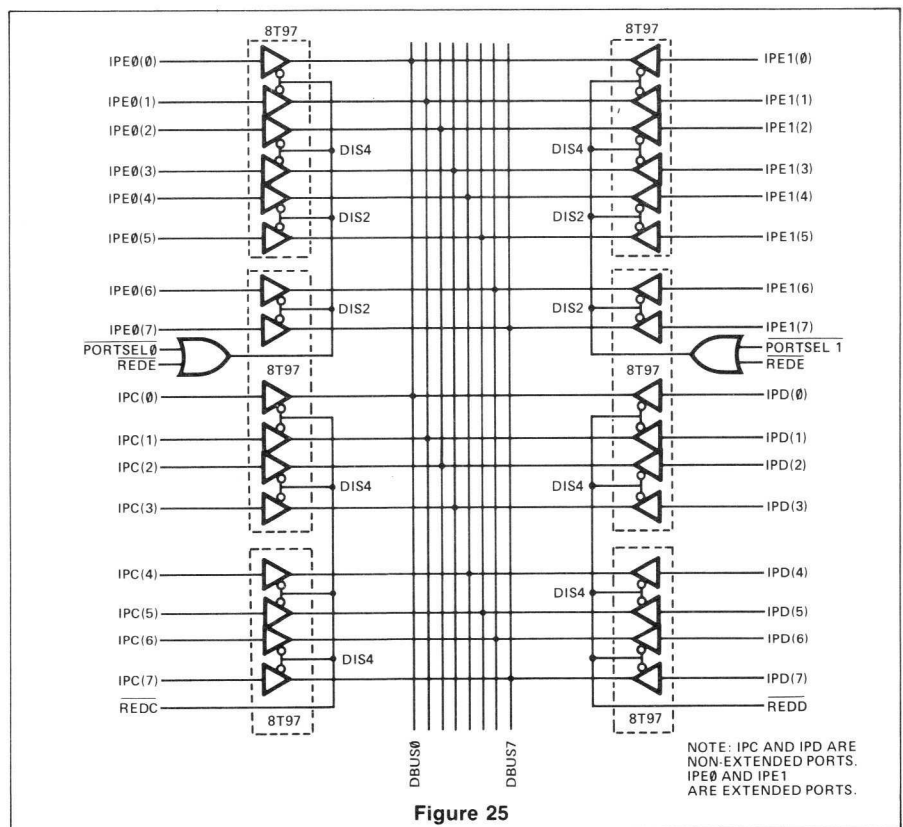
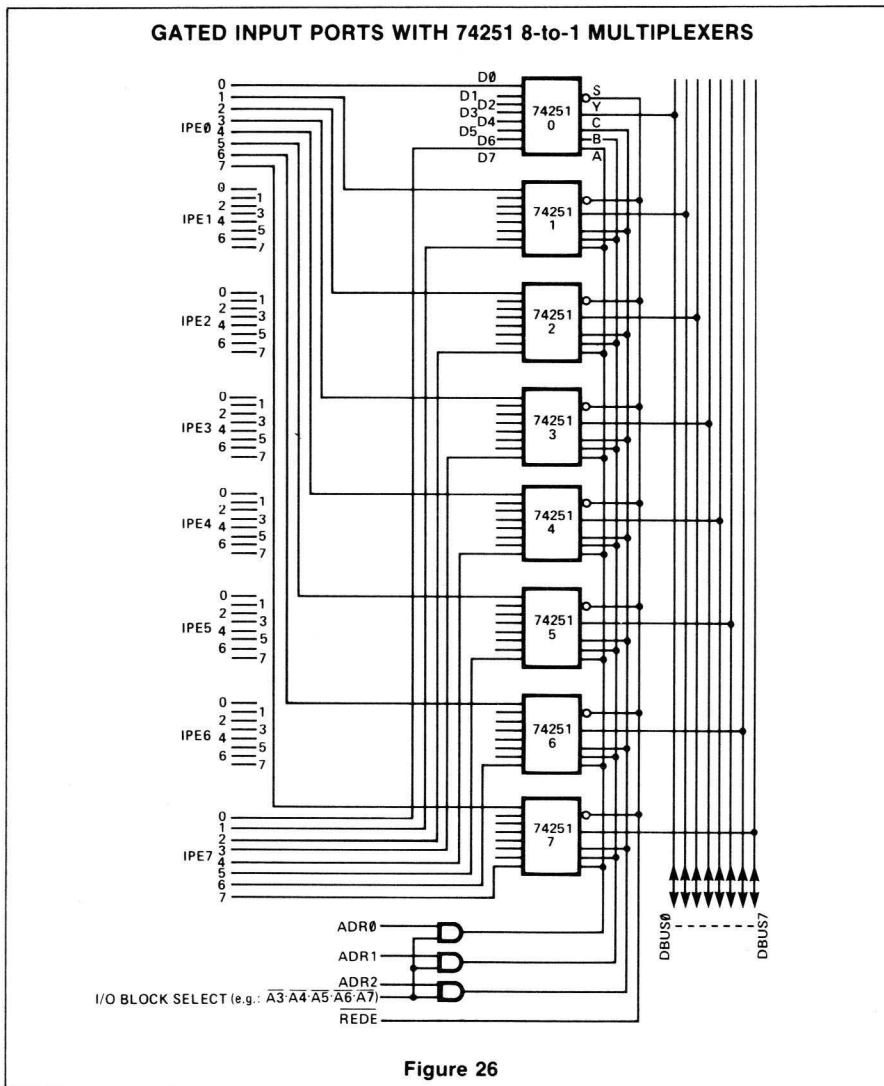


Figure 25



LATCHING INPUT PORTS USING THE 8T10 (74173)

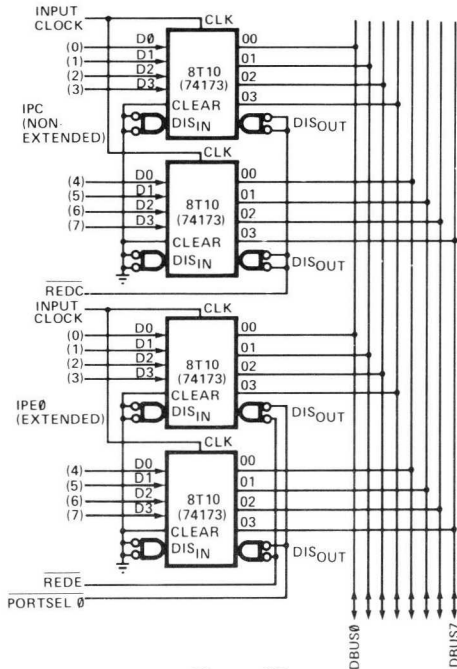


Figure 27

OUTPUT PORTS BUILT WITH STANDARD TTL AND 8T SERIES

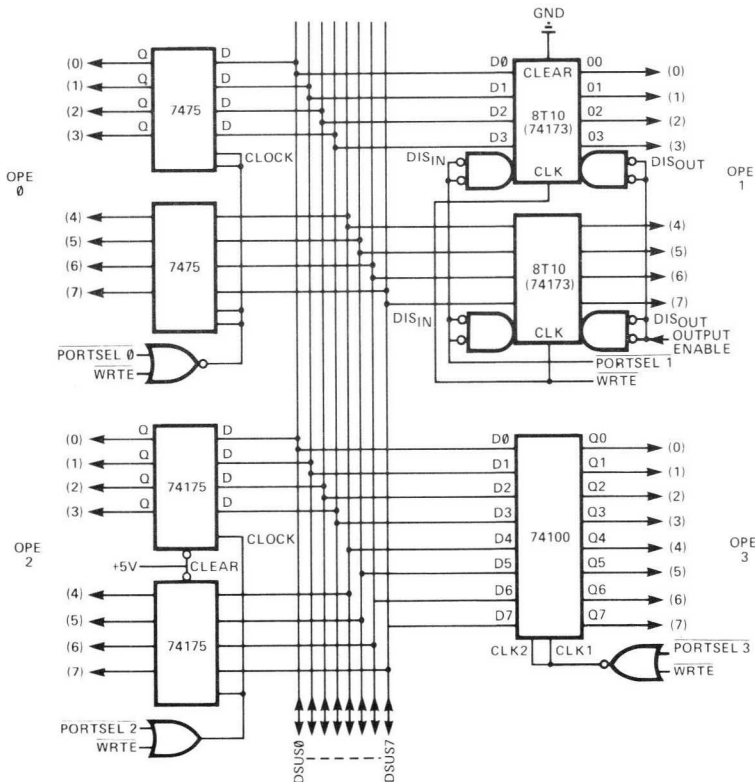


Figure 28

OUTPUT PORT DEVICES

Output ports can be configured with a variety of standard TTL and 8T series flip-flops and registers. Typical circuits include:

- 9334 Addressable 8-bit latch
- 7475 Quadruple latch
- 74100 8-bit latch
- 74175 Quadruple D-type flip-flop
- 8T10 Quadruple D-type flip-flop with tri-state outputs

The 7475 and 74175 both have true and complement outputs. One special feature of the 8T10 is that the outputs may be disabled (placed in a high-impedance output mode) by the device that is connected to this output port. A logic diagram using these circuits for output ports appears in Figure 28.

The 9334 is useful in systems requiring a large number of latched outputs, since a portion of the decoding can be done using the on-chip 3-input decoder. A typical application of this was shown in Figure 23. It is also an efficient circuit for implementing eight 8-bit output ports.

I/O CONFIGURATIONS USING THE 8T31 BIDIRECTIONAL PORT

Functional Description

The 8T31 is an 8-bit bidirectional I/O port consisting of 8 clocked latches with 2 bidirectional I/O buses, each of which has its own control logic. Each bus (A and B) has a read and a write control input, and there is a master enable input for bus B only. The outputs of the latches follow the inputs when the clock is high, and latching will occur when the clock returns low.

The 8T31 is also equipped with a "power-on clear" circuit. If the clock input is held low until the power supply reaches 3.5 volts, the latches will be cleared. There is a logic inversion between bus A and bus B. As a result, when the 8T31 is cleared, bus A will have all logic "1" outputs and bus B all logic "0" outputs.

The control functions of the 8T31 are listed in Table III. A functional block diagram and a symbolic diagram of the 8T31 are illustrated in Figures 29 and 30, respectively.

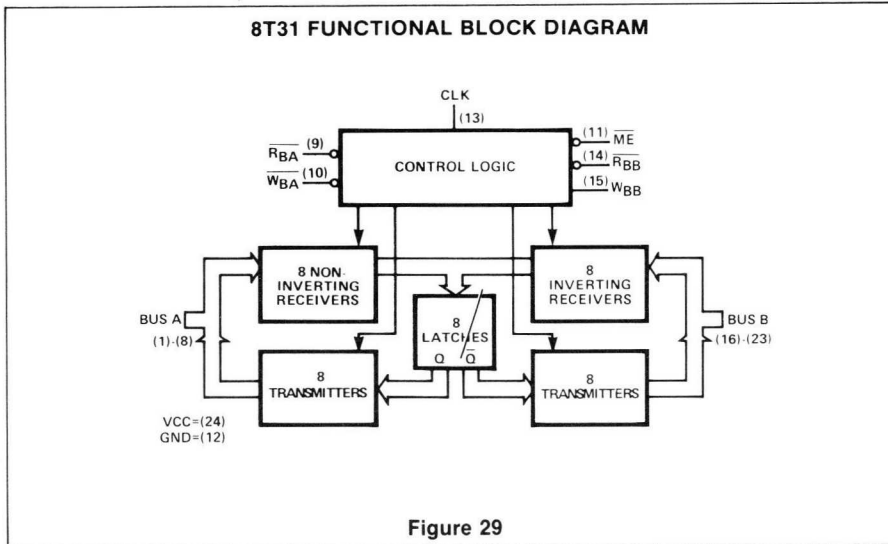


Figure 29

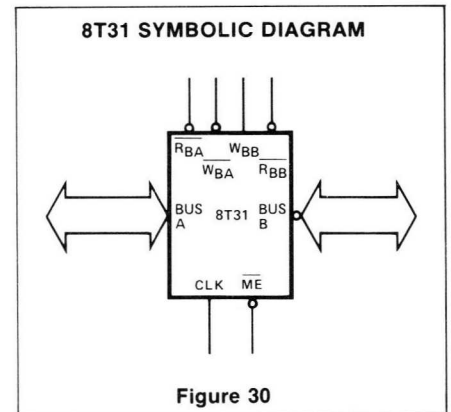


Figure 30

BUS A					
\overline{RBA}	\overline{WBA}	CLK	BUS A		
X	0	1	WRITE (A \rightarrow latch)		
0	1	X	READ (latch \rightarrow A)		
1	1	X	HI-Z (Tri-state)		
BUS B					
\overline{RBB}	\overline{WBB}	\overline{WBA}	CLK	\overline{ME}	BUS B
X	X	X	X	1	HI-Z
1	0	X	X	0	HI-Z
X	1	0	X	0	HI-Z
0	0	X	X	0	READ (latch \rightarrow B)
X	1	1	1	0	WRITE (B \rightarrow latch)

Table 3 8T31 CONTROL FUNCTIONS

As shown in Table III, each bus can operate independently except for the case of writing from both bus A and B. In this case writing from bus A will override any attempt to write from bus B.

8T31 Applications

The control functions of the 8T31 allow it to be used in various microcomputer input/output applications. In the I/O system diagram of Figure 31, the 8T31 is used to implement gated input ports, latching input ports, output ports, and a bidirectional data bus driver. All I/O ports can be controlled directly with the device select and \overline{REDE} and \overline{WRTE} lines coming from device decoders and I/O control logic.

In applications where interfacing is necessary with peripheral devices that need data transfers in two directions, like digital cassettes and data link communication circuits, the 8T31 can be used as a bidirectional I/O port. In this application, the I/O opera-

tion should be requested by interrupt or polling to prevent simultaneous write operations from peripheral and CPU. The bidirectional I/O port concept is illustrated in Figure 32.

Implementing an Eight-Bit Flag Register with the 8T31

In many industrial applications, such as process control, single bit inputs and outputs are used to monitor switches and detectors or to drive relays and lamps. A possible solution for such a flag register would be an eight-bit output port and a memory byte reserved as a flag register in the system's RAM. The setting, resetting, or testing of individual bits with this method of implementing a flag register requires many bytes of program memory. The output port and the memory location reserved as a flag register image must be updated after each bit operation.

The 8T31 can be used to implement a flag register without the use of a memory byte in the system's RAM. No additional hardware is required, and the saving in program memory bytes for flag operations is considerable. A logic diagram of this application is given in Figure 33. Listings of basic software to set, reset, and test individual flags for both positive and negative true outputs are given in Figures 34 and 35.

THE 8T31 USED AS A GATED INPUT PORT, LATCHING INPUT PORT, OUTPUT PORT, AND DATA BUS DRIVER

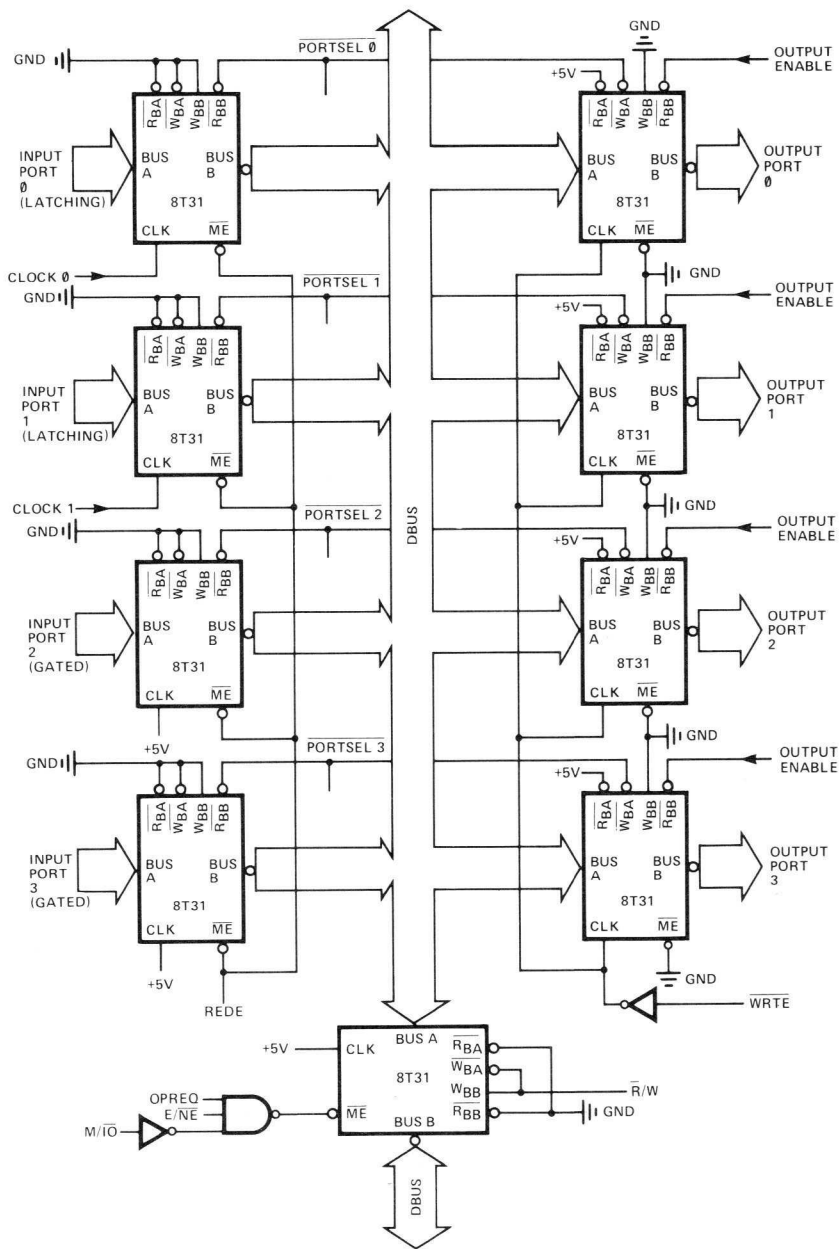


Figure 31

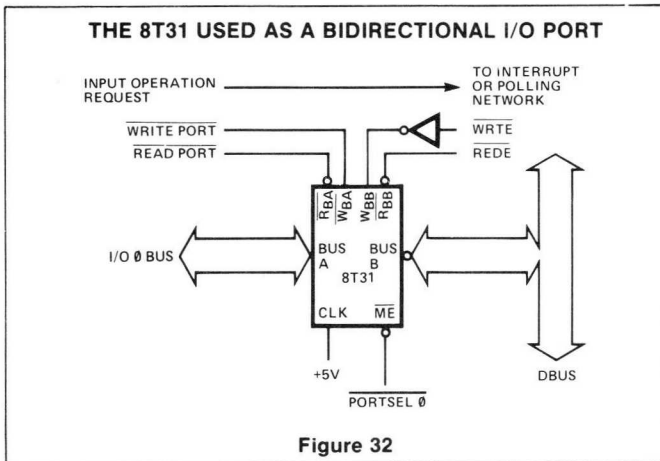


Figure 32

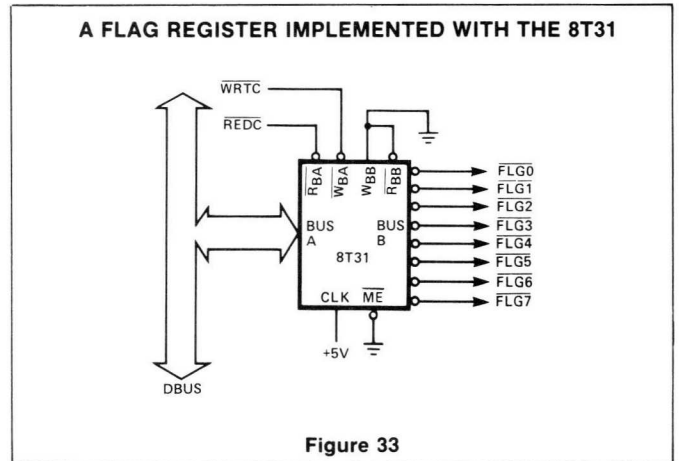


Figure 33

BASIC SOFTWARE FOR FLAG REGISTER OPERATIONS

```

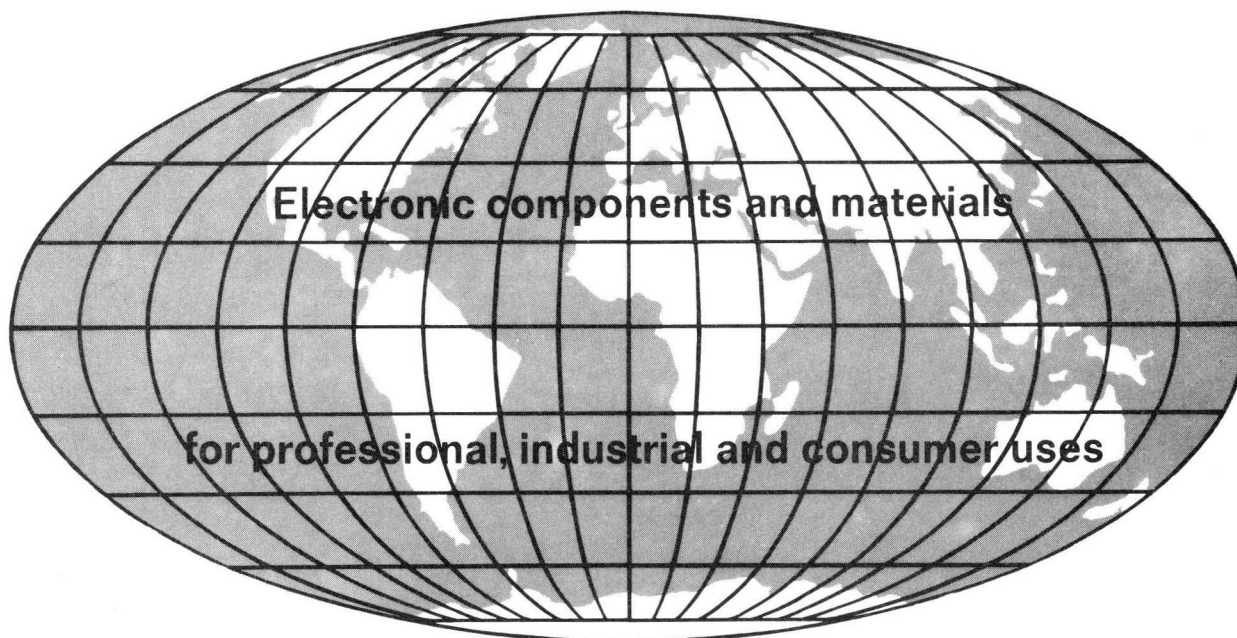
TWIN ASSEMBLER VER 1.0                                PAGE 0001
LINE ADDR OBJECT E SOURCE
0001      * P0760090
0002      *****
0003      *
0004      * **** FLAG MANIPULATION EXAMPLES ****
0005      *
0006      * THIS LISTING GIVES SOME EXAMPLES HOW TO SET, RESET
0007      * AND TEST INDIVIDUAL BITS OF AN EXTERNAL FLAG REGISTER *
0008      * BUILT WITH THE 8T31 BIDIRECTIONAL I/O PORT.
0009      * INSTRUCTIONS ARE GIVEN FOR BOTH ACTIVE 'HIGH' AND
0010      * ACTIVE 'LOW' OUTPUTS
0011      *
0012      *****
0013      *
0014      * DEFINITIONS OF SYMBOLS:
0015      *
0016 0000  R0 EQU 0      PROCESSOR REGISTERS
0017 0001  R1 EQU 1
0018 0002  R2 EQU 2
0019 0003  R3 EQU 3
0020 0000  Z EQU 0      BRANCH COND : ZERO
0021 0003  UN EQU 3     UNCONDITIONAL
0022 0000  AL EQU 0    ALL BITS ARE 1
0023      *
0024 0001  FLG0 EQU H'01' FLAG 0
0025 0002  FLG1 EQU H'02' FLAG 1
0026 0004  FLG2 EQU H'04' FLAG 2
0027 0008  FLG3 EQU H'08' FLAG 3
0028 0010  FLG4 EQU H'10' FLAG 4
0029 0020  FLG5 EQU H'20' FLAG 5
0030 0040  FLG6 EQU H'40' FLAG 6
0031 0080  FLG7 EQU H'80' FLAG 7
0032      *
0033 0600  ONE EQU H'0600' DUMMY ADDRESS OF ROUTINE 'ONE'
0034 0650  ONES EQU H'0650' DUMMY ADDRESS OF ROUTINE 'ONES'
0035      *
0036      *****
0037      *
0038      * ***INSTRUCTIONS FOR ACTIVE 'LOW' OUTPUTS**
0039      *
0040 0000  ORG H'0500'
0041      *
0042      * SET FLAG(S)
0043      *
0044 0500 30  SNFG REDC,R0      LOAD FLAG REGISTER IN R0
0045 0501 6404 IOR1,R0 FLG2      SET FLAG 2
0046 0503 80  WRTC,R0      RESTORE FLAG REGISTER
0047      *
0048 0504 30  SNFS REDC,R0
0049 0505 6406 IOR1,R0 FLG5+FLG6 SET FLAGS 5 AND 6
0050 0507 80  WRTC,R0      RESTORE
0051      *
0052      * RESET FLAG(S)
0053      *
0054 0508 30  RNFG REDC,R0
0055 0509 44FB AND1,R0 H'FF'-FLG2 RESET FLAG 2
0056 050E 80  WRTC,R0      RESTORE
    
```

Figure 34

```

TWIN ASSEMBLER VER 1.0                                PAGE 0002
LINE ADDR OBJECT E SOURCE
0058 050C 30  RNFS REDC,R0
0059 050D 449F AND1,R0 H'FF'-FLG5-FLG6 RESET FLAGS 5 AND 6
0060 050F 80  WRTC,R0      RESTORE
0061      *
0062      * TEST FLAG(S)
0063      *
0064 0510 30  TNFG REDC,R0
0065 0511 F404 TMI,R0 FLG2      TEST FLAG 2
0066 0513 10B600 BCPL,R0 ONE      BRANCH IF ONE
0067      *
0068 0516 30  TNFS REDC,R0
0069 0517 F460 TMI,R0 FLG5+FLG6 TEST FLAGS 5 AND 6
0070 0519 10B650 BCPL,R0 ONES     BRANCH IF BOTH ARE ONE
0071      *
0072      *****
0073      *
0074      * ***INSTRUCTIONS FOR ACTIVE 'HIGH' OUTPUTS**
0075      *
0076 051C  ORG H'0550'
0077      *
0078      * SET FLAG(S)
0079      *
0080 0550 30  SPFG REDC,R0
0081 0551 44FB AND1,R0 H'FF'-FLG2 SET FLAG 2
0082 0553 80  WRTC,R0      RESTORE
0083      *
0084 0554 30  SPFS REDC,R0
0085 0555 44E0 AND1,R0 H'FF'-FLG1-FLG4 SET FLAGS 1 AND 4
0086 0557 80  WRTC,R0      RESTORE
0087      *
0088      * RESET FLAG(S)
0089      *
0090 0558 30  RPFG REDC,R0
0091 0559 6404 IOR1,R0 FLG2      RESET FLAG 2
0092 055B 80  WRTC,R0      RESTORE
0093      *
0094 055C 30  RPF5 REDC,R0
0095 055D 6412 IOR1,R0 FLG1+FLG4 SET FLAGS 1 AND 4
0096 055F 80  WRTC,R0      RESTORE
0097      *
0098      * TEST FLAG(S)
0099      *
0100 0560 30  TPFG REDC,R0
0101 0561 F404 TMI,R0 FLG2      TEST FLAG 2
0102 0563 90B600 BCPL,R0 ONE      BRANCH IF ONE
0103      *
0104 0566 30  TPFS REDC,R0
0105 0567 F412 TMI,R0 FLG1+FLG4 TEST FLAGS 1 AND 4
0106 0569 90B650 BCPL,R0 ONES     BRANCH IF BOTH ARE ONE
0107      *
0108 0000  END 0
TOTAL ASSEMBLY ERRORS = 0000
    
```

Figure 35



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